

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/790,734	MIKURIYA ET AL.
	Examiner	Art Unit
	John L. Goodrow	1756

SEARCHED

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
430	109.1	5/17/06	JG
	109.31		